	_	**	•						
• • •					Application/Control No.		Applicant(s)	Applicant(s)/Patent Under	
		Notice of References Cited			10/621,755		HAN, KE	Reexamination HAN, KE	
		Notice of Neterence	es Oneu		Examiner		Art Unit	Dans 4 of 4	
	•				Leila Malek	•	2611	2611 Page 1 of 1	
			<u>-</u>	U.S. P	ATENT DOCUM	ENTS		·	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY			Name		Classification	
*	Α	US-6,590,972	07-2003	Lu et a	l.			379/283	
	В	US-							
	С	US-							
	D	US-							
	E	US-							
	F	US-							
	G	US-							
	н	US-							
	ı	US-							
	J	US-							
	к	US-					.	·	
	L	US-							
	М	US-							
				FOREIGN	PATENT DOC	JMENTS			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	(Country	Na	ame	Classification	
	N			,			<u> </u>		
	0								
	Р								
	Q								
	R								
	s				ļ				
	Т	,							
				NON-P	Examiner Leila Malek PATENT DOCUMENTS Name Classification al. 379/283 N PATENT DOCUMENTS Country Name Classification Classification Classification Classification Classification Classification				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	υ								
					···				
	\ \								
	W								
					•				

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.